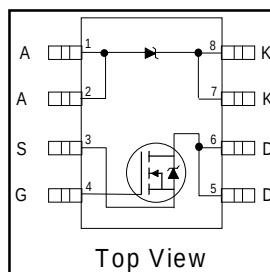


International  
**IR** Rectifier

# IRF7523D1

**FETKY™** MOSFET / Schottky Diode

- Co-packaged HEXFET® Power MOSFET and Schottky Diode
- N-Channel HEXFET
- Low  $V_F$  Schottky Rectifier
- Generation 5 Technology
- Micro8™ Footprint

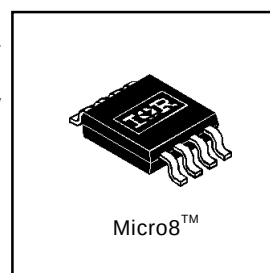


|                           |
|---------------------------|
| $V_{DS} = 30V$            |
| $R_{DS(on)} = 0.11\Omega$ |
| Schottky $V_f = 0.39V$    |

## Description

The **FETKY™** family of co-packaged HEXFETs and Schottky diodes offer the designer an innovative board space saving solution for switching regulator applications. Generation 5 HEXFETs utilize advanced processing techniques to achieve extremely low on-resistance per silicon area. Combining this technology with International Rectifier's low forward drop Schottky rectifiers results in an extremely efficient device suitable for use in a wide variety of portable electronics applications like cell phone, PDA, etc.

The new Micro8™ package, with half the footprint area of the standard SO-8, provides the smallest footprint available in an SOIC outline. This makes the Micro8™ an ideal device for applications where printed circuit board space is at a premium. The low profile (<1.1mm) of the Micro8™ will allow it to fit easily into extremely thin application environments such as portable electronics and PCMCIA cards.



## Absolute Maximum Ratings ( $T_A = 25^\circ C$ unless otherwise noted)

| Parameter                |                                              | Maximum     | Units |
|--------------------------|----------------------------------------------|-------------|-------|
| $I_D @ T_A = 25^\circ C$ | Continuous Drain Current, $V_{GS}@10V^{(4)}$ | 2.7         | A     |
| $I_D @ T_A = 70^\circ C$ |                                              | 2.1         |       |
| $I_{DM}$                 |                                              | 21          |       |
| $P_D @ T_A = 25^\circ C$ | Power Dissipation <sup>(4)</sup>             | 1.25        | W     |
| $P_D @ T_A = 70^\circ C$ |                                              | 0.8         |       |
|                          | Linear Derating Factor                       | 10          | W/°C  |
| $V_{GS}$                 | Gate-to-Source Voltage                       | $\pm 20$    | V     |
| dv/dt                    | Peak Diode Recovery dv/dt <sup>(2)</sup>     | 6.2         | V/ns  |
| $T_J, T_{STG}$           | Junction and Storage Temperature Range       | -55 to +150 | °C    |

## Thermal Resistance Ratings

| Parameter       |                                    | Maximum | Units |
|-----------------|------------------------------------|---------|-------|
| $R_{\theta JA}$ | Junction-to-Ambient <sup>(4)</sup> | 100     | °C/W  |

### Notes:

- ① Repetitive rating; pulse width limited by maximum junction temperature (see figure 11)
- ②  $I_{SD} \leq 1.7A$ ,  $di/dt \leq 120A/\mu s$ ,  $V_{DD} \leq V_{(BR)DSS}$ ,  $T_J \leq 150^\circ C$
- ③ Pulse width  $\leq 300\mu s$ ; duty cycle  $\leq 2\%$
- ④ When mounted on 1 inch square copper board to approximate typical multi-layer PCB thermal resistance

**MOSFET Electrical Characteristics @  $T_J = 25^\circ\text{C}$  (unless otherwise specified)**

| Parameter     | Min.                            | Typ.  | Max.  | Units    | Conditions                                                                 |
|---------------|---------------------------------|-------|-------|----------|----------------------------------------------------------------------------|
| $V_{(BR)DSS}$ | 30                              | —     | —     | V        | $V_{GS} = 0V, I_D = 250\mu A$                                              |
| $R_{DS(on)}$  | —                               | 0.090 | 0.130 | $\Omega$ | $V_{GS} = 10V, I_D = 1.7A$ ③                                               |
|               |                                 | 0.140 | 0.190 |          | $V_{GS} = 4.5V, I_D = 0.85A$ ③                                             |
| $V_{GS(th)}$  | 1.0                             | —     | —     | V        | $V_{DS} = V_{GS}, I_D = 250\mu A$                                          |
| $g_{fs}$      | 1.9                             | —     | —     | S        | $V_{DS} = 10V, I_D = 0.85A$                                                |
| $I_{DSS}$     | —                               | —     | 1.0   | $\mu A$  | $V_{DS} = 24V, V_{GS} = 0V$                                                |
|               |                                 |       | 25    |          | $V_{DS} = 24V, V_{GS} = 0V, T_J = 125^\circ\text{C}$                       |
| $I_{GSS}$     | Gate-to-Source Forward Leakage  | —     | —     | nA       | $V_{GS} = -20V$                                                            |
|               | Gate-to-Source Reverse Leakage  | —     | 100   |          | $V_{GS} = 20V$                                                             |
| $Q_g$         | Total Gate Charge               | —     | 7.8   | 12       | $I_D = 1.7A$<br>$V_{DS} = 24V$<br>$V_{GS} = 10V$ (see figure 6) ③          |
| $Q_{gs}$      | Gate-to-Source Charge           | —     | 1.2   | 1.8      |                                                                            |
| $Q_{gd}$      | Gate-to-Drain ("Miller") Charge | —     | 2.5   | 3.8      |                                                                            |
| $t_{d(on)}$   | Turn-On Delay Time              | —     | 4.7   | —        | $V_{DD} = 15V$<br>$I_D = 1.7A$<br>$R_G = 6.1\Omega$<br>$R_D = 8.7\Omega$ ③ |
| $t_r$         | Rise Time                       | —     | 10    | —        |                                                                            |
| $t_{d(off)}$  | Turn-Off Delay Time             | —     | 12    | —        |                                                                            |
| $t_f$         | Fall Time                       | —     | 5.3   | —        |                                                                            |
| $C_{iss}$     | Input Capacitance               | —     | 210   | —        | $V_{GS} = 0V$<br>$V_{DS} = 25V$<br>$f = 1.0\text{MHz}$ (see figure 5)      |
| $C_{oss}$     | Output Capacitance              | —     | 80    | —        |                                                                            |
| $C_{rss}$     | Reverse Transfer Capacitance    | —     | 32    | —        |                                                                            |

**MOSFET Source-Drain Ratings and Characteristics**

| Parameter | Min. | Typ. | Max. | Units | Conditions                                                     |
|-----------|------|------|------|-------|----------------------------------------------------------------|
| $I_S$     | —    | —    | 1.25 | A     |                                                                |
| $I_{SM}$  | —    | —    | 21   |       |                                                                |
| $V_{SD}$  | —    | —    | 1.2  | V     | $T_J = 25^\circ\text{C}, I_S = 1.7A, V_{GS} = 0V$              |
| $t_{rr}$  | —    | 40   | 60   | ns    | $T_J = 25^\circ\text{C}, I_F = 1.7A$<br>$di/dt = 100A/\mu s$ ③ |
| $Q_{rr}$  | —    | 48   | 72   | nC    |                                                                |

**Schottky Diode Maximum Ratings**

|             | Parameter                                        | Max. | Units | Conditions                                                                                  |
|-------------|--------------------------------------------------|------|-------|---------------------------------------------------------------------------------------------|
| $I_{F(av)}$ | Max. Average Forward Current                     | 1.9  | A     | 50% Duty Cycle. Rectangular Wave, $T_A = 25^\circ\text{C}$                                  |
|             |                                                  | 1.3  |       | See Fig.14<br>$T_A = 70^\circ\text{C}$                                                      |
| $I_{SM}$    | Max. peak one cycle Non-repetitive Surge current | 120  | A     | 5 $\mu s$ sine or 3 $\mu s$ Rect. pulse                                                     |
|             |                                                  | 11   |       | 10ms sine or 6ms Rect. pulse<br>Following any rated load condition & with $V_{RRM}$ applied |

**Schottky Diode Electrical Specifications**

|          | Parameter                    | Max. | Units      | Conditions                                         |
|----------|------------------------------|------|------------|----------------------------------------------------|
| $V_{FM}$ | Max. Forward voltage drop    | 0.50 | V          | $I_F = 1.0A, T_J = 25^\circ\text{C}$               |
|          |                              | 0.62 |            | $I_F = 2.0A, T_J = 25^\circ\text{C}$               |
|          |                              | 0.39 |            | $I_F = 1.0A, T_J = 125^\circ\text{C}$              |
|          |                              | 0.57 |            | $I_F = 2.0A, T_J = 125^\circ\text{C}$              |
| $I_{RM}$ | Max. Reverse Leakage current | 0.06 | mA         | $V_R = 30V, T_J = 25^\circ\text{C}$                |
|          |                              | 16   |            | $T_J = 125^\circ\text{C}$                          |
| $C_t$    | Max. Junction Capacitance    | 92   | pF         | $V_R = 5Vdc$ ( 100kHz to 1 MHz) $25^\circ\text{C}$ |
| $dv/dt$  | Max. Voltage Rate of Charge  | 3600 | V/ $\mu s$ | Rated $V_R$                                        |

### Power Mosfet Characteristics

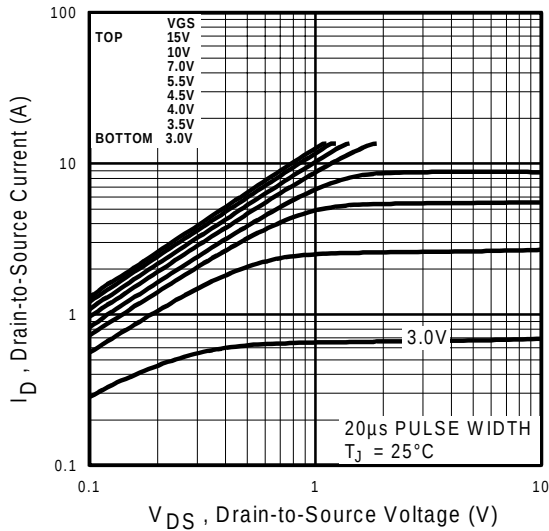


Fig 1. Typical Output Characteristics

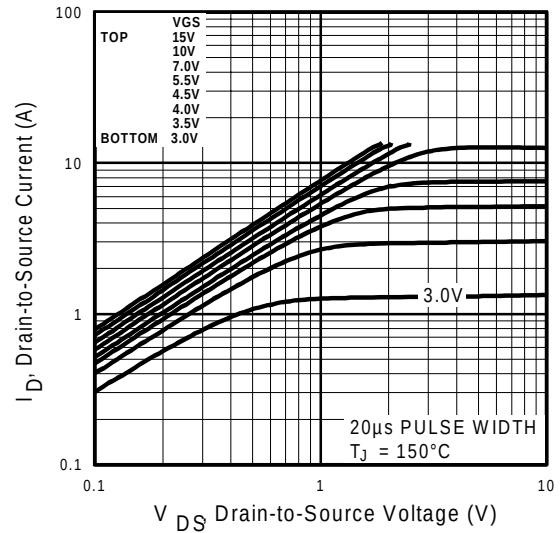


Fig 2. Typical Output Characteristics

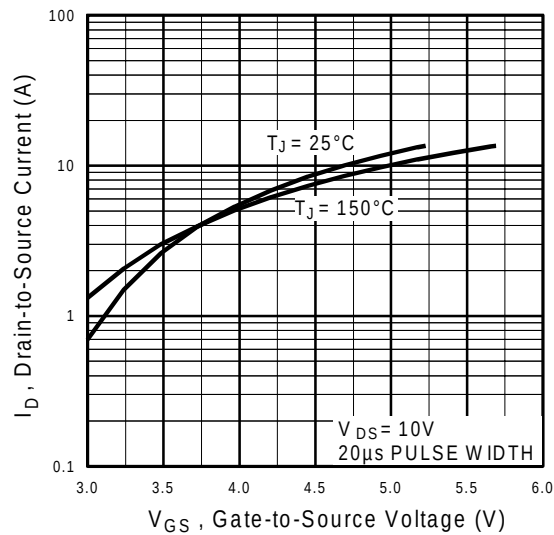


Fig 3. Typical Transfer Characteristics

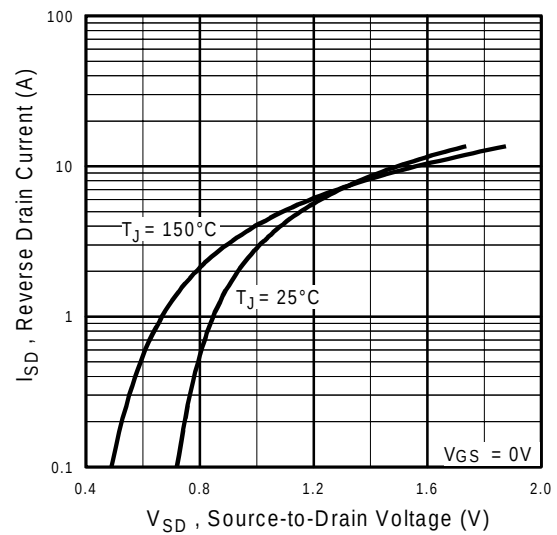
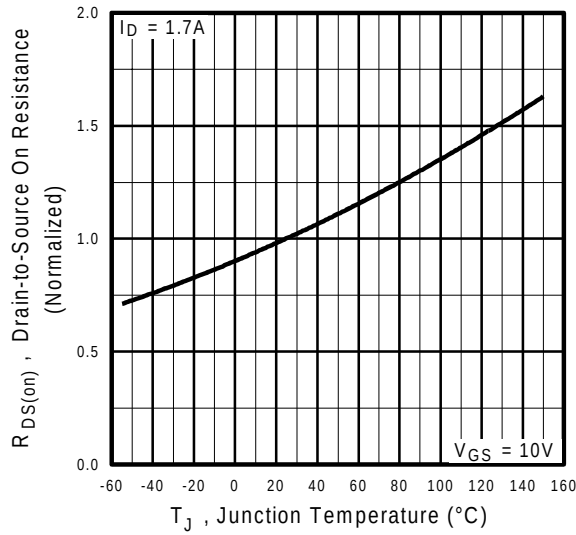
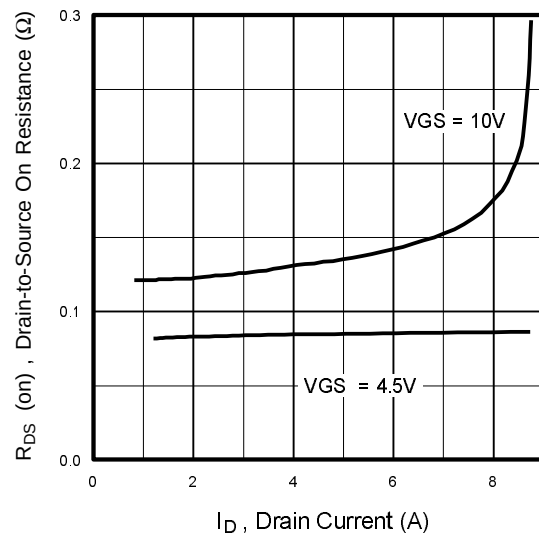


Fig 4. Typical Source-Drain Diode  
Forward Voltage

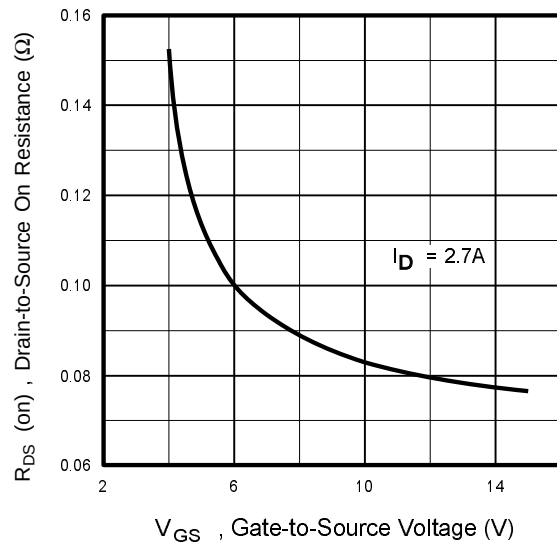
Power Mosfet Characteristics



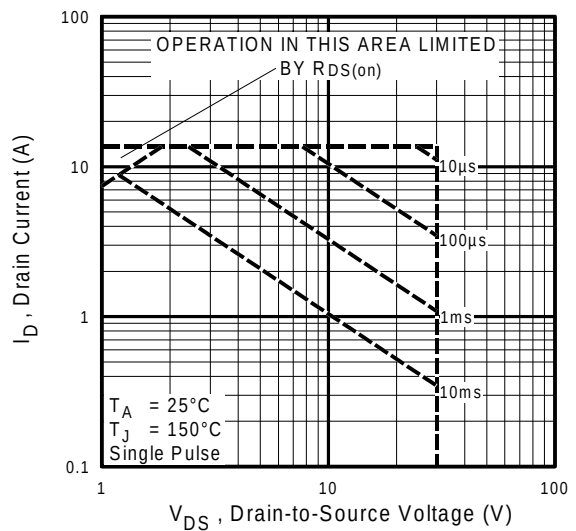
**Fig 5.** Normalized On-Resistance Vs. Temperature



**Fig 6.** Typical On-Resistance Vs. Drain Current

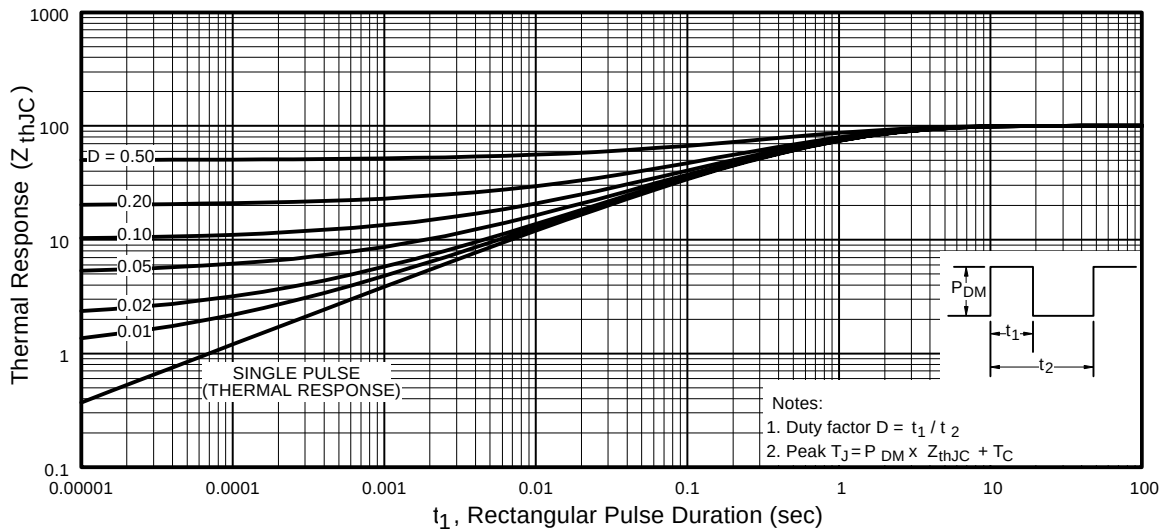
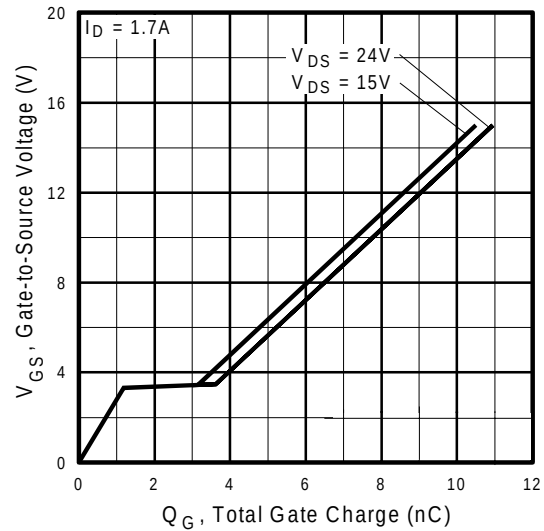
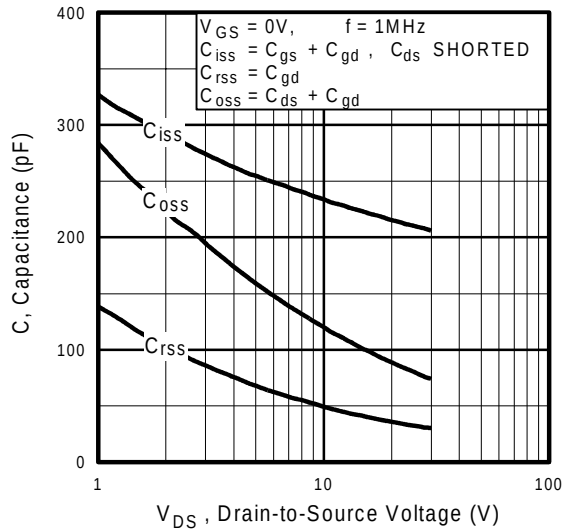


**Fig 7.** Typical On-Resistance Vs. Gate Voltage

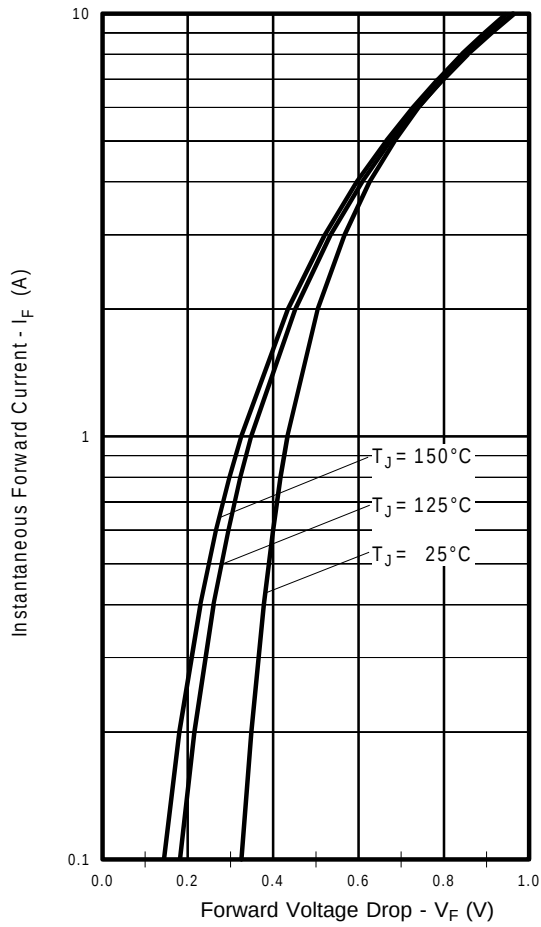


**Fig 8.** Maximum Safe Operating Area

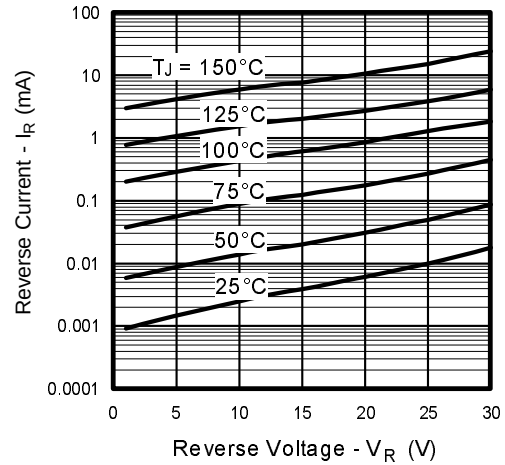
# Power Mosfet Characteristics



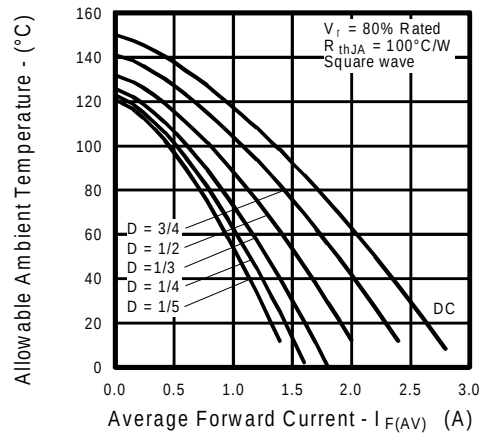
# Schottky Diode Characteristics



**Fig. 12** -Typical Forward Voltage Drop Characteristics

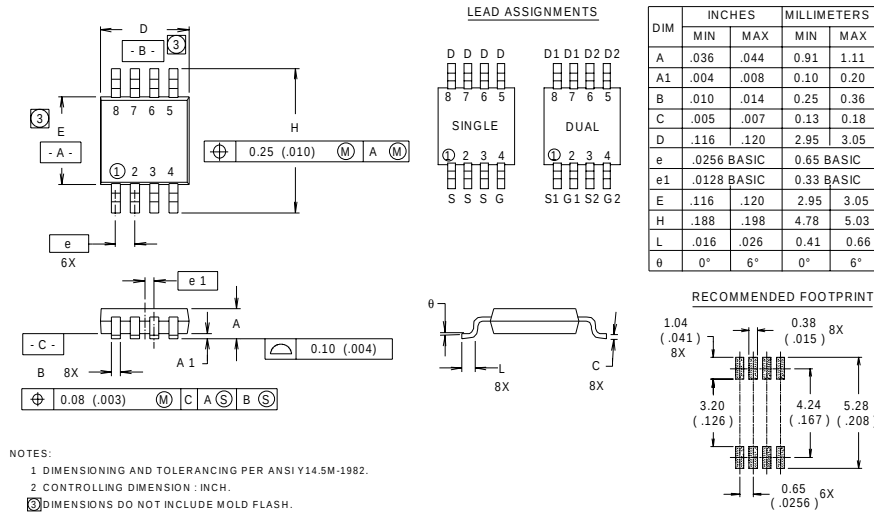


**Fig. 13** - Typical Values of Reverse Current Vs. Reverse Voltage



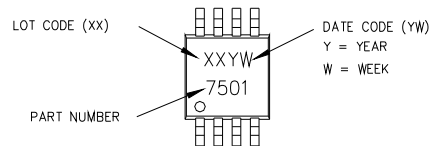
**Fig.14** - Maximum Allowable Ambient Temp. Vs. Forward Current

## Micro8™ Package Details



## Part Marking

EXAMPLE: THIS IS AN IRF7501



WW = (1-26) IF PRECEDED BY LAST DIGIT OF CALENDAR YEAR

DATE CODE EXAMPLES:

YWW = 9503 = 5C

YWW = 9532 = EF

| YEAR | Y | WORK WEEK | W |
|------|---|-----------|---|
| 2001 | 1 | 01        | A |
| 2002 | 2 | 02        | B |
| 2003 | 3 | 03        | C |
| 1994 | 4 | 04        | D |
| 1995 | 5 |           |   |
| 1996 | 6 |           |   |
| 1997 | 7 |           |   |
| 1998 | 8 |           |   |
| 1999 | 9 |           |   |
| 2000 | 0 | 24        | X |
|      |   | 25        | Y |
|      |   | 26        | Z |

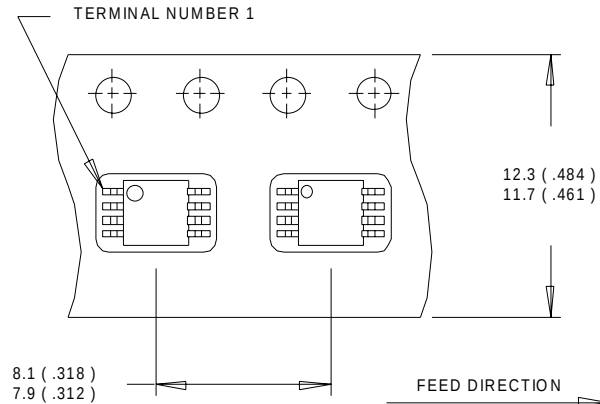
WW = (27-52) IF PRECEDED BY A LETTER

| YEAR | Y | WORK WEEK | W |
|------|---|-----------|---|
| 2001 | A | 27        | A |
| 2002 | B | 28        | B |
| 2003 | C | 29        | C |
| 1994 | D | 30        | D |
| 1995 | E |           |   |
| 1996 | F |           |   |
| 1997 | G |           |   |
| 1998 | H |           |   |
| 1999 | J |           |   |
| 2000 | K | 50        | X |
|      |   | 51        | Y |
|      |   | 52        | Z |

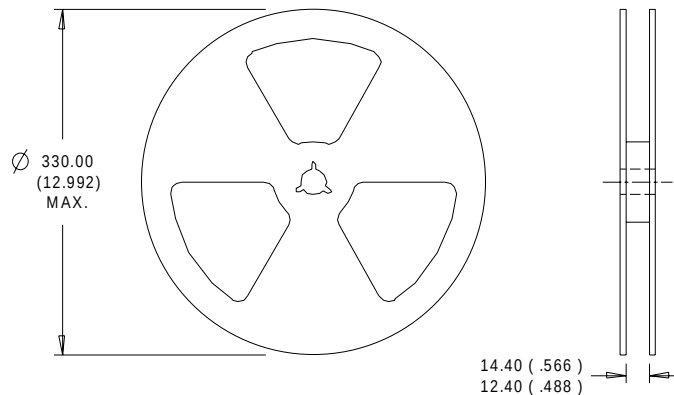
# IRF7523D1

International  
**IR** Rectifier

## Micro8™ Tape & Reel



- NOTES:
1. OUTLINE CONFORMS TO EIA-481 & EIA-541.
  2. CONTROLLING DIMENSION : MILLIMETER.



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1. CONTROLLING DIMENSION : MILLIMETER.
  2. OUTLINE CONFORMS TO EIA-481 & EIA-541.

International  
**IR** Rectifier

**WORLD HEADQUARTERS:** 233 Kansas St., El Segundo, California 90245, Tel: (310) 322 3331

**IR GREAT BRITAIN:** Hurst Green, Oxted, Surrey RH8 9BB, UK Tel: ++ 44 1883 732020

**IR CANADA:** 15 Lincoln Court, Brampton, Ontario L6T3Z2, Tel: (905) 453 2200

**IR GERMANY:** Saalburgstrasse 157, 61350 Bad Homburg Tel: ++ 49 6172 96590

**IR ITALY:** Via Liguria 49, 10071 Borgaro, Torino Tel: ++ 39 11 451 0111

**IR FAR EAST:** K&H Bldg., 2F, 30-4 Nishi-Ikebukuro 3-Chome, Toshima-Ku, Tokyo Japan 171 Tel: 81 3 3983 0086

**IR SOUTHEAST ASIA:** 1 Kim Seng Promenade, Great World City West Tower, 13-11, Singapore 237994 Tel: ++ 65 221 8371

**IR TAIWAN:** 16 Fl. Suite D. 207, Sec. 2, Tun Haw South Road, Taipei, 10673, Taiwan Tel: 886-2-2377-9936

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